

High reflectivity grating waveguide coatings for 1064 nm

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Abstract

We propose thin single-layer grating waveguide structures to be used as high reflectivity, but low thermal noise, alternative to conventional coatings for gravitational wave detector test mass mirrors. Grating waveguide (GWG) coatings can show a reflectivity of up to 100% with an overall thickness of less than a wavelength. We theoretically investigate GWG coatings for 1064 nm based on tantalum pentoxide (Ta_2O_5) on a silica substrate focusing on broad spectral response and low thickness.

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1. Introduction

Dedicated research during the last few years has revealed that thermally driven motion of the test masses, the so-called thermal noise [1], is larger than foreseen in future gravitational wave detectors. A major, but previously underestimated, contribution is given by the multilayer dielectric coating stacks of the high reflectivity test mass mirrors [2, 3]. This currently limits the design sensitivity of the advanced LIGO detector [4]. In conventional schemes, up to 40 layers of Ta_2O_5 and SiO_2 with an optical thickness of a quarter wavelength are needed to reach high reflectivities sufficiently close to 100%. The thermal noise of the coating is due to the mechanical loss of the layers with a dominant contribution from Ta_2O_5 . New concepts are required that have less loss but still achieve the required high reflectivity. One approach being pursued is to design an alternative multilayer system deviating from the classical quarter wave design and containing less Ta_2O_5 [5]. Doping of Ta_2O_5 with TiO_2 has also been investigated and a reduction of the loss by a factor of 1.5 was observed [6]. Another approach is to avoid high reflection coatings at all by the use of corner reflectors which employ total internal reflection instead of multiple interference at different layers to reach high reflectivity [7]. However, in this case thermo-refractive noise which results from a temperature-dependent

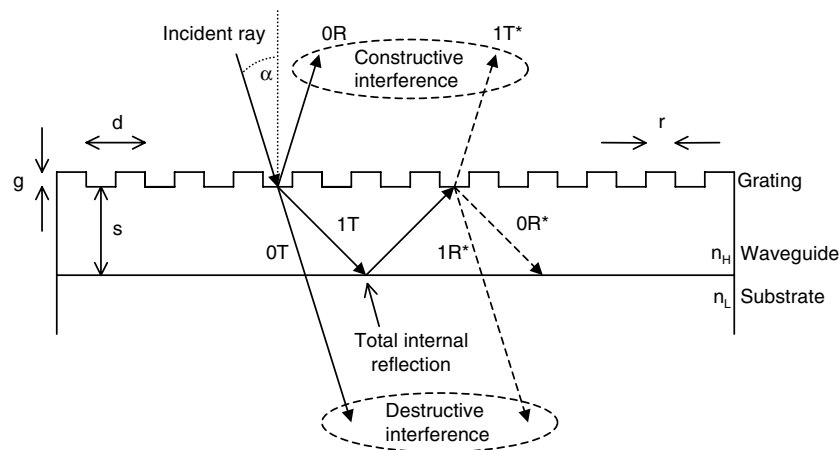


Figure 1. Schematic of a grating waveguide structure in a simplified ray picture. For clarity, a non-zero angle of incidence and only one first-order transmission are shown.

refractive index and also thermal lensing are increased due to the large optical path length in the substrate material.

Grating waveguide structures [8] provide another possibility of constructing high reflectivity devices. The interest of earlier work on grating waveguides lay mainly in narrow-band (highly resonant) devices for applications in optical filtering [9] and optical switching [10]. However, grating waveguide structures can also provide broadband (weakly resonant) reflectors. This makes them interesting candidates for test mass coatings in gravitational wave detectors, because only a very small amount of dielectric coating material is required which results in a considerable reduction in coating thermal noise.

2. Resonant grating waveguide structures

The remarkable property of a grating waveguide (GWG) is that it can show a reflectivity of 100% for a given optical wavelength λ despite its thickness of typically less than a micron. For an extensive overview of grating waveguides we refer to [11]. In the simplest case, a GWG consists of a substrate material with low refractive index n_L followed by a waveguide layer with high refractive index n_H which has periodic corrugation with period d as shown in figure 1. A simplified ray picture [8] can be used to understand its behaviour. The structure can be designed such that light incident onto the grating will only produce one diffraction order in reflection (0R) but three diffraction orders in transmission (0T and $\pm 1T$). (For clarity, the $-1T$ order has been omitted in figure 1.)

The first-order beams are coupled into a layer of high refractive material where they are stored due to total internal reflection. Light inside the waveguide is also coupled out via the grating. For a proper choice of grating parameters and incident angle, the light coupled out from the layer (1R*) interferes destructively with the zero-order transmitted beam (0T) and the device is a perfect reflector.

The possible parameter range for the period d depends on the angle of incidence α , the (vacuum) laser wavelength λ (λ_0), and the refractive indices n_L and n_H and can be calculated

from the grating equation

$$\sin \alpha + \sin \beta_m = m\lambda/d, \quad (1)$$

where β_m is the angle of the m th diffraction order. For test mass mirrors in gravitational wave detector Michelson interferometers, the angle of incidence is typically restricted to $\alpha = 0$. To ensure that only the $m = 0$ order is allowed in reflection,

$$d < \lambda_0 \quad (2)$$

has to hold. Another condition is that only $|m| \leq 1$ orders in transmission exist from which follows that

$$1 < d \frac{n_H}{\lambda_0} < 2. \quad (3)$$

Total internal reflection of the first order at the boundary of the waveguide and the substrate material is ensured if

$$d < \lambda_0/n_L. \quad (4)$$

A resonant grating waveguide structure has analogous behaviour to a Fabry–Perot resonator: with decreasing coupling to the waveguide the finesse of the structure increases [8]. For high reflectors in GW detectors high finesse structures are disadvantageous, because small deviations from the design parameter would dramatically decrease the reflectivity for the desired wavelength λ_0 . Additionally, the power build-up inside a high finesse waveguide could be a problem for high-power laser interferometers. Accordingly, a broadband resonance is desired for the high reflector.

3. Spectral response of waveguide coatings

Using Rigorous-Coupled-Wave (RCW) analysis [12] it is possible to calculate the optical properties of the structure. Design considerations for binary gratings must include groove depth g , waveguide thickness s and ridge width r , see figure 1, in addition to the above-mentioned period d and refractive indices n_L and n_H . The goal is to design a broadband reflection being less sensitive to fabrication tolerances and avoiding the problem of strong light power build-up in the waveguide. Here, we restrict ourselves to $n_H = 2.04$ and $n_L = 1.45$. This corresponds to tantala and fused silica which are the favourite high index coating material and test mass material, respectively [2].

According to (2)–(4) the following constraints apply to the period when one assumes the commonly used Nd:YAG laser wavelength of $\lambda_0 = 1064$ nm:

$$521 \text{ nm} < d < 734 \text{ nm}. \quad (5)$$

For a broadband response, the calculated coupling to the waveguide which corresponds to the diffraction efficiency of the ± 1 T ray should be maximized. It only depends on the grating properties g and r/d but not on the thickness s of the waveguiding layer. Figure 2 shows how the coupling depends on the groove depth g and fill factor (r/d) for selected values of d for TM (magnetic field vector is parallel to the grooves) illumination. The plots indicate that the maximum coupling increases with increasing period d . This is illustrated in figure 3 where we plotted the maximum values of the coupling obtained when g and r/d were varied according to figure 2 versus grating period d for TM and TE polarization. Hence, for the purpose of a broadband reflection peak large values for the grating period are favourable.

The direct connection between coupling and spectral width of the resonance is illustrated in figure 4. The right-hand side of the figure again shows the coupling to the waveguide

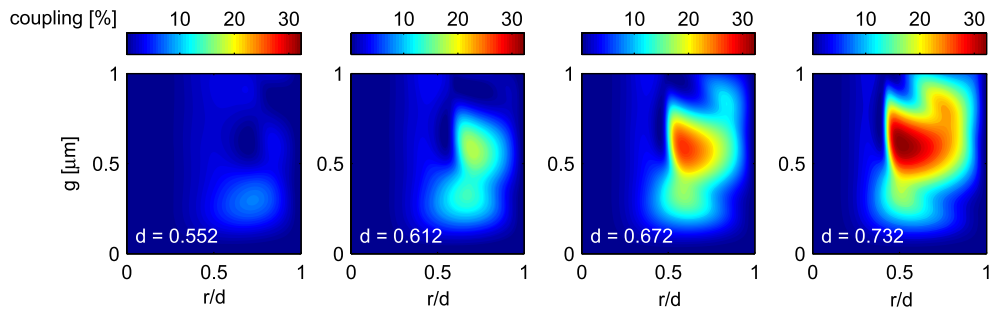


Figure 2. Coupling to the waveguide for each of the ± 1 T rays (colour-coded) versus groove depth g and fill factor r/d for TM illumination and selected values of d .

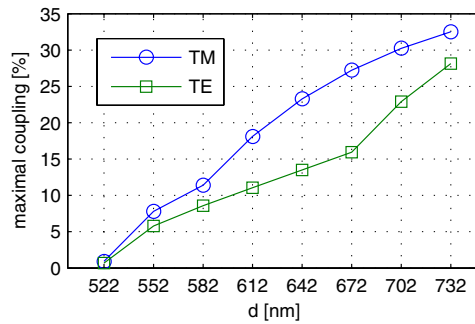


Figure 3. Maximum achievable coupling per diffraction order ± 1 T for TM and TE polarization versus grating period d . For each point the groove depth was varied between 0 and 1 μm and the fill factor between 0 and 1.

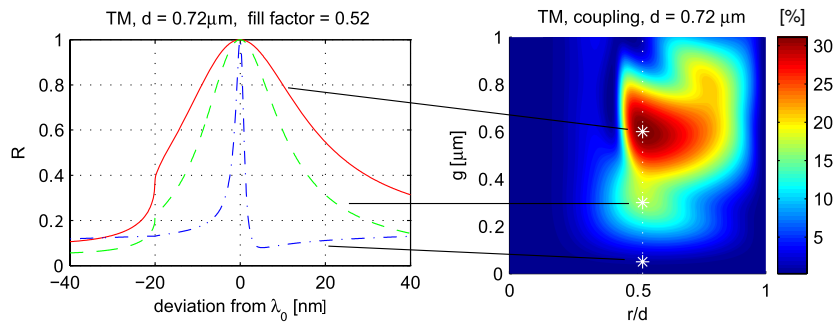


Figure 4. Right: TM coupling to the waveguide (colour-coded) versus groove depth and fill factor. Left: spectral response of three waveguide structures corresponding to the marked values in the right figure. From a deviation of greater than -20 nm inequality (4) is no longer fulfilled which leads to the kinks in the curves.

versus groove depth and fill factor for a specific grating period. For three selected values of the groove depth (marked with three asterisks) and fixed fill factor, we determined the optimal waveguide thickness s_0 for a resonance peak around $\lambda_0 = 1064$ nm. On the left-hand side of figure 4, we show the calculated reflectivity versus the deviation from λ_0 for the corresponding waveguide coating.

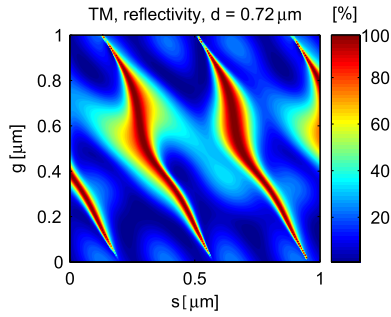


Figure 5. Colour-coded TM reflectivity of a waveguide structure versus groove depth and waveguide thickness s . The values for d , r/d and g correspond to the dotted line in figure 4 (right). In this case, 100% reflectivity can be obtained for vanishing layer thickness at a groove depth of $g \approx 0.39 \mu\text{m}$.

We note that for materials with higher refractive index than $n_{\text{H}} = 2.04$ higher diffraction efficiencies (couplings to the waveguide) and therefore even broader reflection peaks are possible [13, 14].

4. Thickness of the coating

The crucial factor for coating thermal noise in gravitational wave detector test masses is the overall thickness of the high index coating material. To reach a reflectivity of $1 - R = 10$ ppm with a $\lambda/4$ stack of SiO_2 and Ta_2O_5 , typically 40 layers are needed, adding up to $20\lambda/(4n_{\text{H}}) \approx 2.6 \mu\text{m}$ overall tantala thickness. In contrast to this, a grating waveguide mirror can get along with a tantala thickness of much less than a wavelength.

In addition, if the total thickness of tantala in the waveguide structure is to be compared with a conventional mirror, one has to take into account that the grating region is not uniformly filled. Hence to first-order approximation one can assume that the coating thermal noise should be proportional to an effective tantala thickness of $s + g(r/d)$.

The layer thickness s determines the phase of the light travelling in the waveguide and hence the resonance condition of the device. The thickness s_0 for which a resonance occurs varies if the grating parameters g , r and d are changed as illustrated exemplary in figure 5, where the calculated power reflectivity is plotted versus the groove depth and the waveguide thickness. One can see a periodic behaviour of the reflectivity as s varies as expected. More interesting to note is that for a certain value of g the 100% reflectivity resonance occurs at $s = 0$. Accordingly, the grating itself can provide perfect reflection and no waveguide layer is needed. This is extremely useful since the amount of the high index material can be greatly reduced. For vanishing waveguide layer thickness, the explanation of the device via the ray picture presented in figure 1 seems to break down. However, the results are based on a RCW analysis which is still valid for $s = 0$.

An optimal design of a grating waveguide coating for gravitational wave detectors will be a trade-off between the broadest spectral response and the smallest effective tantala thickness. As an example, we consider the GWG corresponding to the dashed (green) curve on the left-hand side of figure 4 which still has $\Delta\lambda_{\text{FWHM}} \approx 22$ nm. With $g = 0.3 \mu\text{m}$ and $s \approx 0.06 \mu\text{m}$, the effective tantala thickness is only about $0.24 \mu\text{m}$. This suggests a thermal noise reduction by more than an order of magnitude compared to a conventional coating.

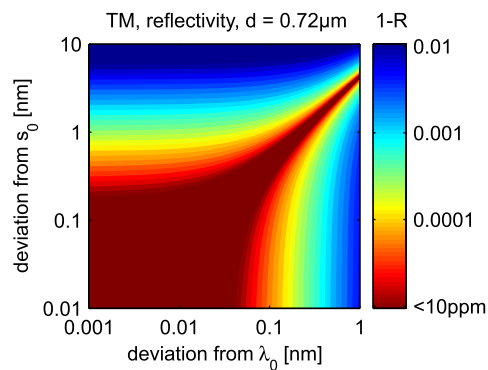


Figure 6. (Colour-coded) Reflectivity plotted as $1-R$ versus the deviation from optimal wavelength λ_0 and deviation from optimal waveguide thickness $s_0 \approx 239$ nm. Other parameters for the grating: $g = 0.6 \mu\text{m}$; $r/d = 0.52$.

5. Parameter tolerances

When designing diffractive structures one also has to consider how accurately grating parameters and layer thicknesses can be manufactured by state-of-the-art procedures and how strongly deviations from design values affect the performance of the waveguide coating. Here, we consider the fabrication errors in the waveguide thickness and how they can be compensated by tuning the laser wavelength. Figure 6 shows how the power reflectivity R of a waveguide is affected when the thickness of the waveguide or the wavelength of the laser deviates from their optimal values s_0 and λ_0 , respectively. A typical power reflectivity requirement for GW detectors is $(1 - R) < 10$ ppm. Typical production accuracies of thin films are on the order of 1 nm. The deviation from s_0 could be compensated by tuning the laser wavelength to a small fraction of a nanometre. Deviations in other grating parameters affect the reflectivity by a similar way.

6. Conclusion

We have proposed a high reflectivity grating waveguide coating for advanced gravitational wave detectors which can provide perfect reflection despite the small amount of coating material that is needed. This has great potential to lower the coating thermal noise of high reflectivity mirrors. Focusing on a laser wavelength of $\lambda_0 = 1064$ nm and tantala as the coating material we presented sample calculations of the spectral response of the coating as well as the overall tantala thickness of the coating. Our analysis was based on RCW analysis and assumed plane wave inputs as well as infinite gratings. Future theoretical work will include Gaussian input beams and finite grating size effects. On top of that more sophisticated designs of grating waveguide structures such as double periodic structures [15] or double gratings [16] will also be investigated. Future experimental work will aim for a detailed characterization of such devices as an alternative to conventional high reflectivity multilayer dielectric coating stacks. An important issue will be the reduction of optical losses that may arise from writing errors during grating fabrication.

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